

Kudos to Our Reviewers... and a Big Thanks!

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# Kudos to Our Reviewers... and a Big Thanks!

**T**HE ability of IEEE TRANSACTIONS ON ELECTRON DEVICES (T-ED) to publish high-quality papers critically depends upon the competence, diligence, and generosity of reviewers who voluntarily contribute their time for this purpose. The T-ED Editorial Board and I are well aware of our dependence on high-quality and timely reviews and wish to acknowledge and recognize the individuals from inside and out of the Electron Devices Society (EDS) who have so selflessly contributed to this effort. Within EDS, contributing to the welfare of the Society and to the promotion of its goals is widely regarded as a duty of each member. Acting as a reviewer is one way to accomplish this duty.

In reality, we know that many reviewers volunteer for nobler reasons than a mere sense of duty. They are truly dedicated to making a difference in the quality of research and scholarship that EDS disseminates. This unseen, but well-recognized, *quality stamp* is the hallmark of the TRANSACTIONS and one of the principal ways that the TRANSACTIONS distinguishes itself from the ubiquitous publication noise in which most of us are immersed.

We reviewed more than three thousand T-ED manuscripts in the last twelve months and published about one-third of these. On the website of the IEEE Electron Device Society (see the link <https://eds.ieee.org/publications/transactions-on-electron-devices/golden-reviewers>), a list is available of the women and men who have done a particularly good job as reviewers by virtue of the timeliness, thoroughness, and thoughtfulness of their comments. We publicly salute you, and

we ask our readers to express thanks to all of the individuals on this list that you know or will encounter. They deserve your gratitude, now more than ever.

This is also the right time for me to express a big Thanks! to all those who have helped me as the T-ED Editor-in-Chief (EiC) since January 2016. After seven years, I will step down from the EiC position at the end of 2022. My gratitude goes to the editorial board, which has carefully processed an average of more than three papers per month per editor with timeliness and high standards of quality, to the former T-ED EiCs, and to the EDS Presidents and Vice-Presidents for Publications, for their continuous help and support, and, last but not at all least, to the T-ED technical staff (a particular thanks goes to Marlene James and the now retired Rosemary Schreiber, not to mention others) for their constant help and availability, weekends, and holidays included.

Finally, my best wishes go to Patrick Fay, who will replace me as the T-ED EiC starting from January 2023. I am sure that under Patrick's leadership T-ED will maintain and improve its standards of quality and fast time to publication. Thanks again!

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